## Applicant(s)/Patent Under Application/Control No. Reexamination 10/015,421 TATHGUR ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Philip H Leung 3742 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-3,723,212 03-1973 Casper 219/769 Α 29/840 В US-4,334,354 06-1982 Luft et al. US-С US-D US-Ε F US-G US-US-Н US-US-US-Κ

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